



HIROSHIMA UNIVERSITY



Pressure-induced quantum critical phenomena in YbNiGe_3

K. Umeo

N-BARD, Hiroshima Univ.

Collaborators:

N. Hosogi, T. Takabatake, ADSM, Hiroshima Univ.

M. A. Avila, Federal University of ABC

Abstract

The electrical resistivity of a single crystal YbNiGe_3 has been measured under pressures up to 6.5 GPa and at temperatures down to 0.3K. The resistivity is described as $\rho(T) = \rho_0 + AT^n$ at $T < 20$ K. The coefficient A increases by a factor of 10 with increasing pressure from 3.6 GPa to 6.5 GPa. For $P > 3.6$ GPa, the exponent n decreases below 2, and reaches 1.6 at 6.5 GPa. This value is close to 1.5 expected at the quantum critical point by the spin-fluctuation theory for a three-dimensional antiferromagnet. These findings suggest that the quantum critical point in YbNiGe_3 is located at approximately 8 GPa.

1. Introduction

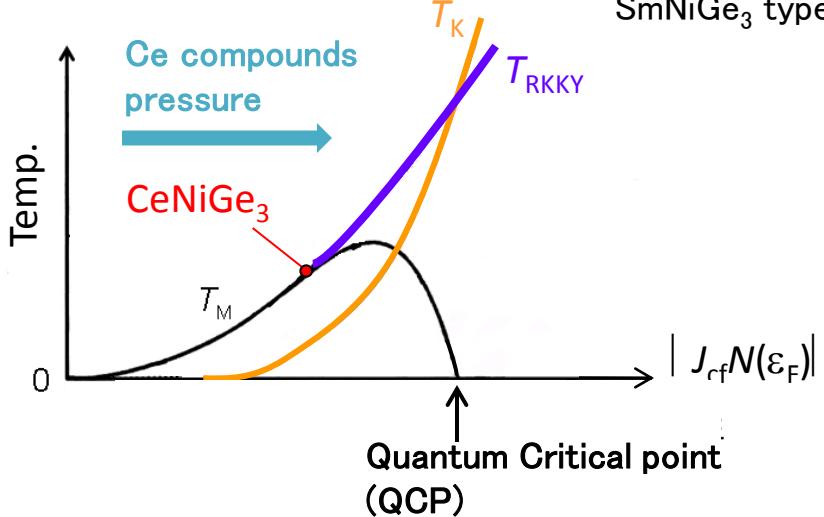
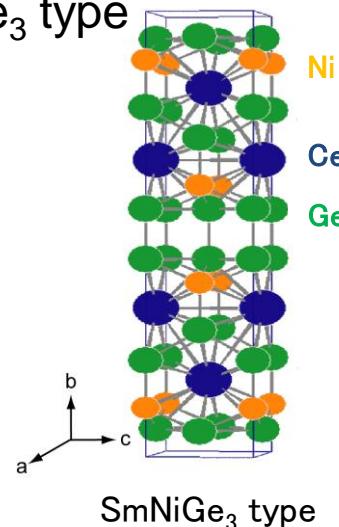
Pressure-induced superconductivity in a heavy-fermion antiferromagnet CeNiGe₃ [1,2]

- CeNiGe₃
Orthorhombic SmNiGe₃ type

$$T_M = 5.5 \text{ K} @ P = 0$$

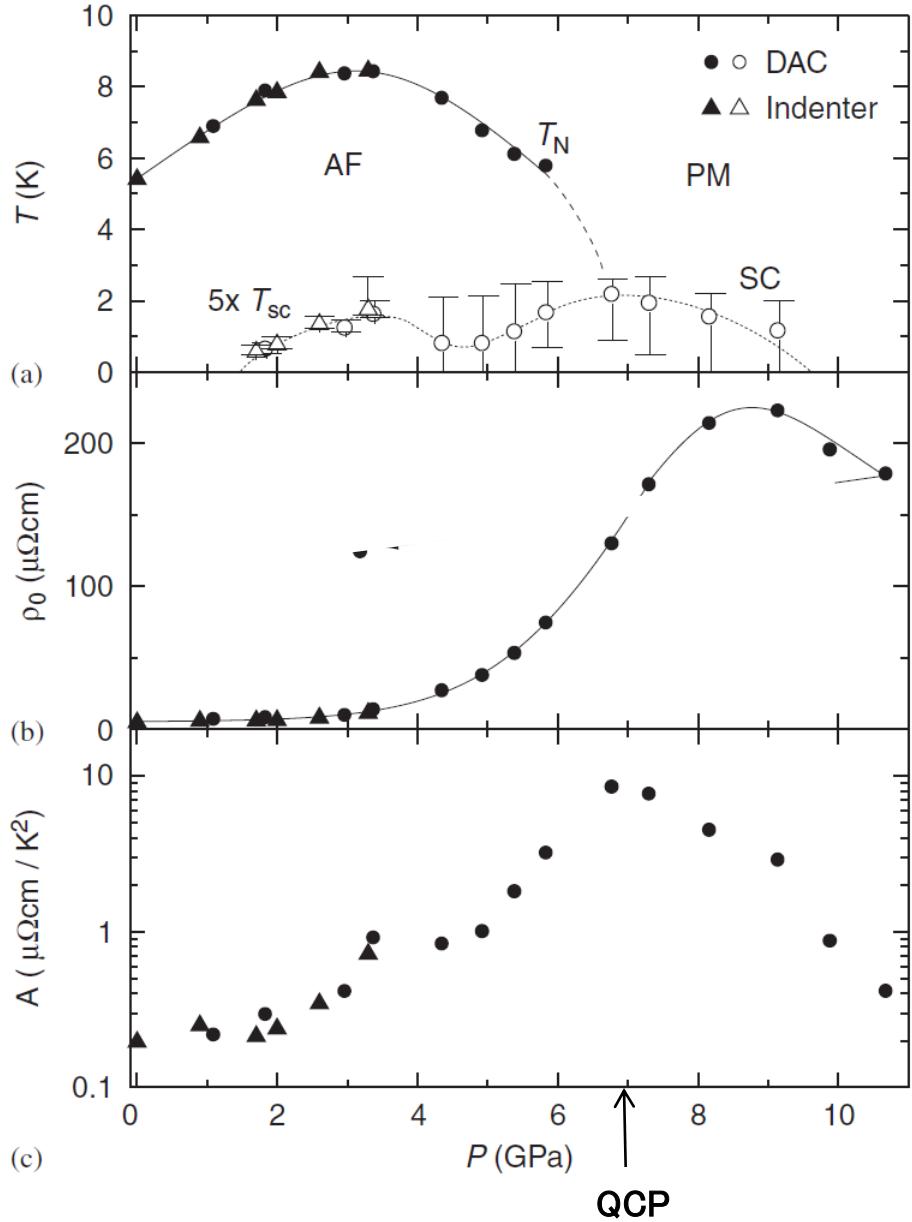
$$P_c \sim 6\text{-}7 \text{ GPa} [1,2]$$

$$T_{SC} \sim 0.4 \text{ K} [1,2]$$



$$\rho = \rho_0 + AT^2$$

ρ_0 and A have a maximum around QCP.



Search for a pressure-induced superconductivity in Yb compounds ③

- YbNiSi_3

Orthorhombic SmNiGe_3 type same as CeNiGe_3

Heavy-fermion antiferromagnet ($T_N = 5.1 \text{ K}$) [3-5]

- YbNiGe_3

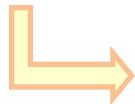
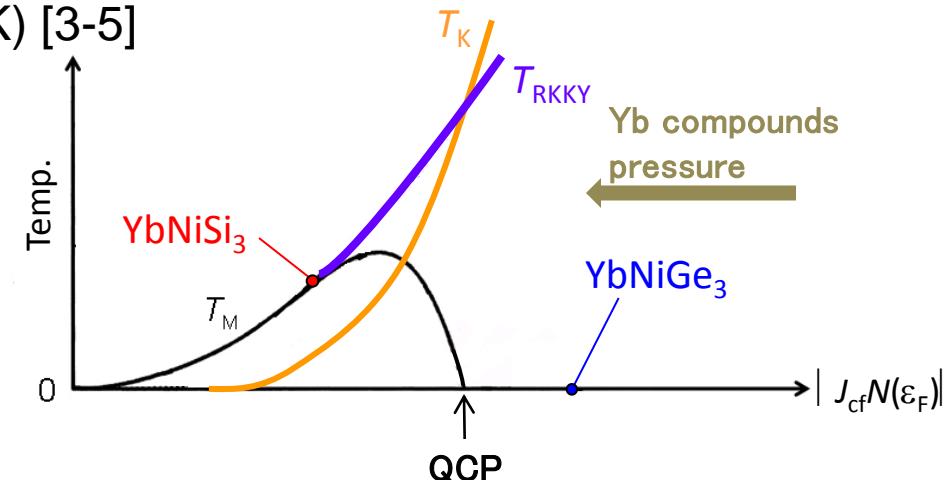
Orthorhombic SmNiGe_3 type

Non-magnetic ground state at $P = 0$

Unit cell volume (V_{UC}) is larger by 12%
than that for YbNiSi_3 [4,5]



$$V_{\text{UC}}(\text{YbNiGe}_3 @ P=11 \text{ GPa}) = V_{\text{UC}}(\text{YbNiSi}_3 @ P=0) \\ (\text{if the bulk modulus is } 100 \text{ GPa.})$$



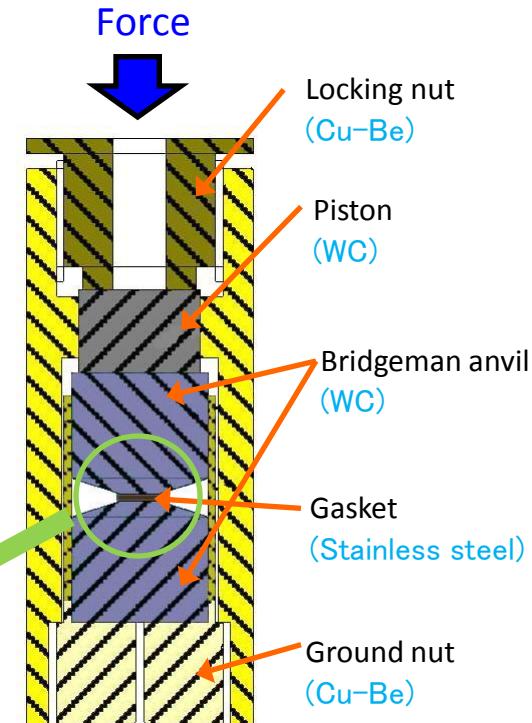
When YbNiGe_3 is pressurized, we expect that the ground state changes to a magnetically ordered state through the QCP.

Purpose : Search for a pressure-induced superconductivity in YbNiGe_3

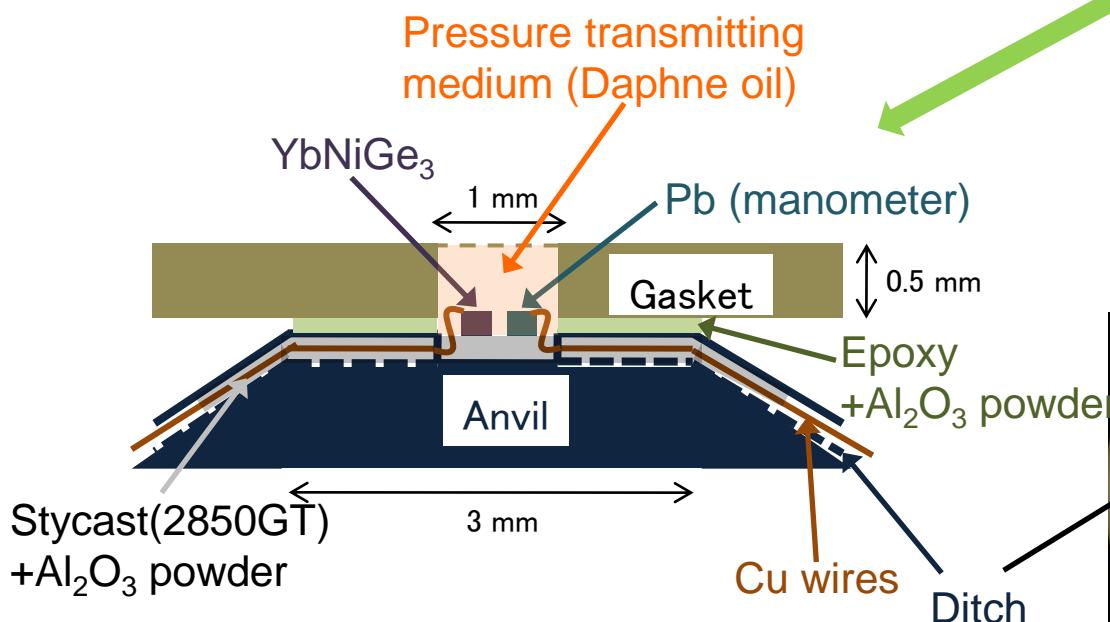
2. Experimental procedure

Electrical resistivity measurement
ac four-terminal method
Clamp type pressure cell
 $T : 0.3 \sim 300 \text{ K}$ (${}^3\text{He}$ cryostat)

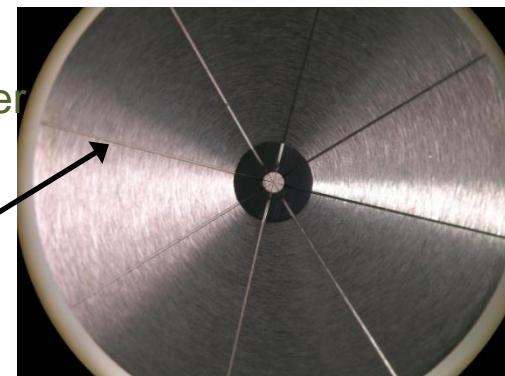
Bridgman anvil cell



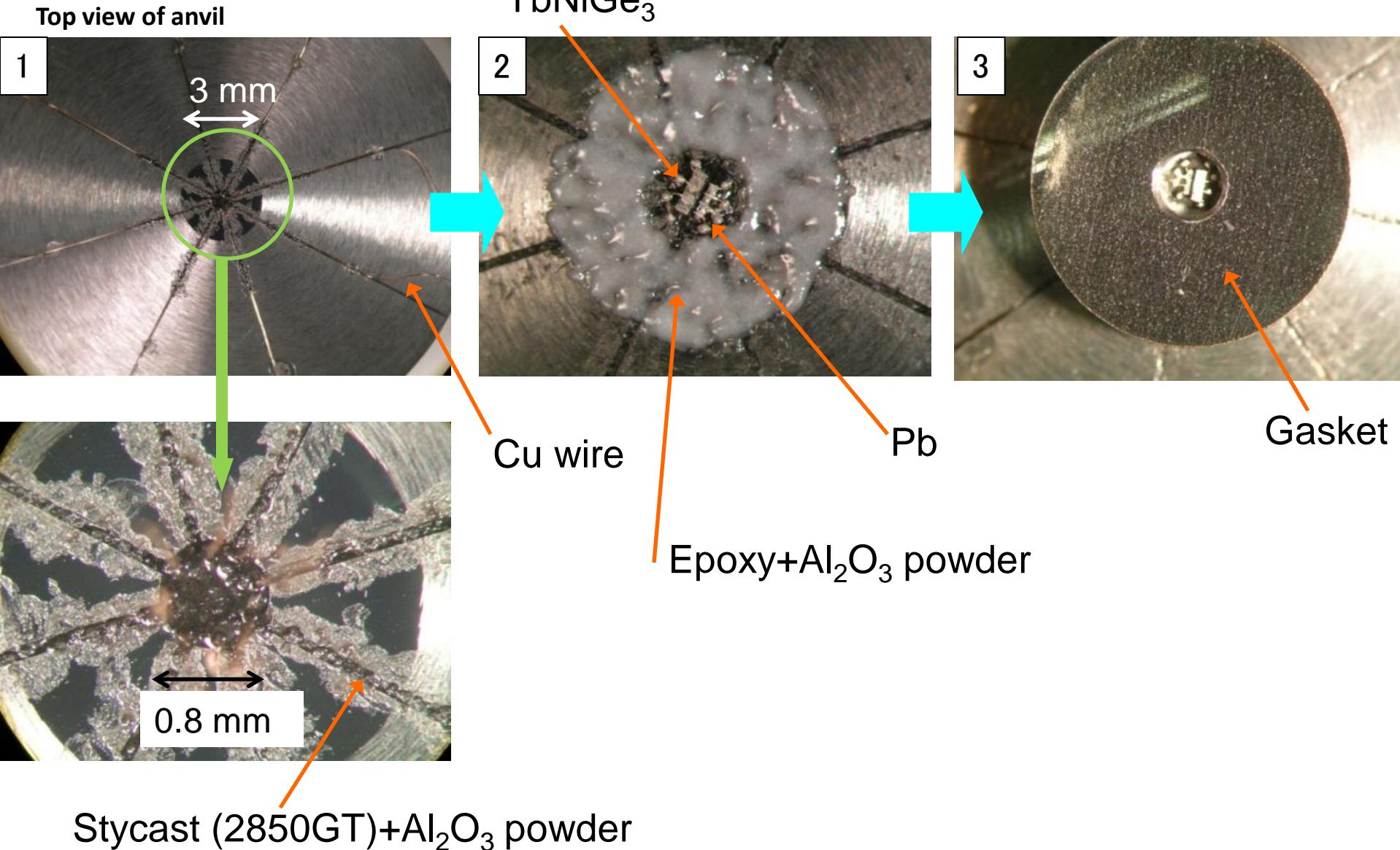
Cross section of the sample space [6]



Top view of anvil

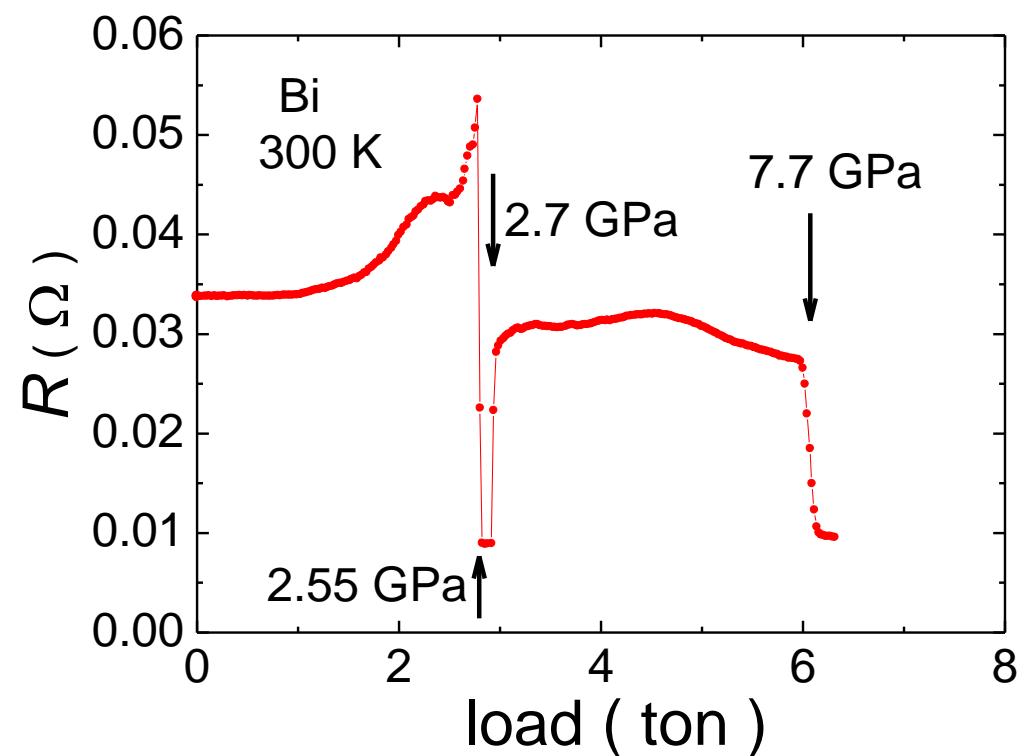


Setting of the samples

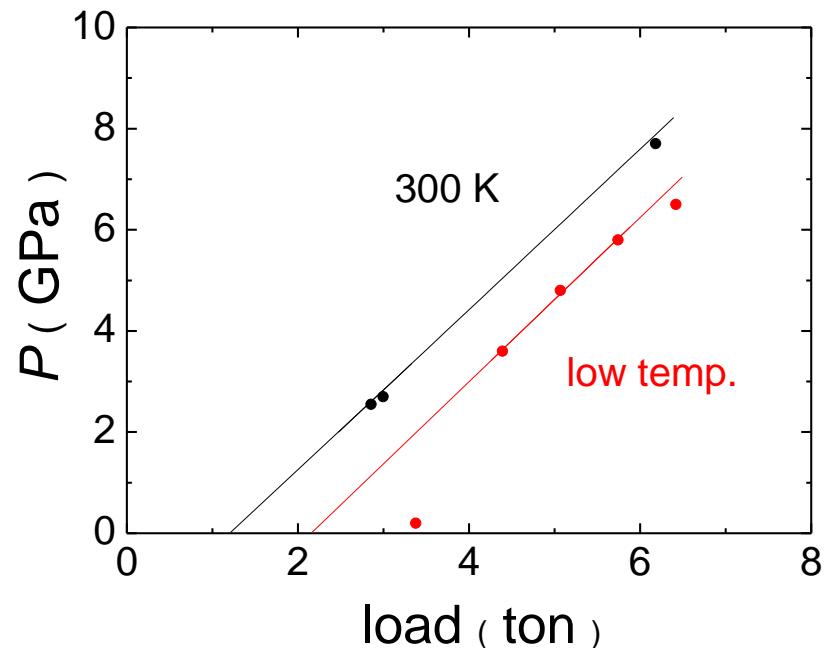


3. Results

Pressure effect on the resistivity of Bi at room temp.

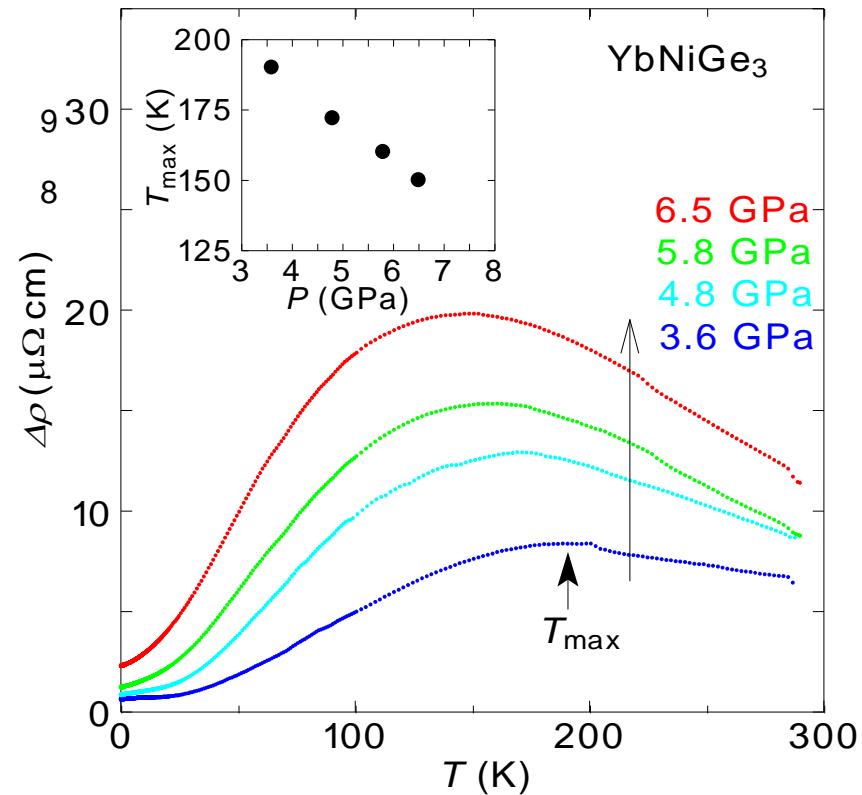
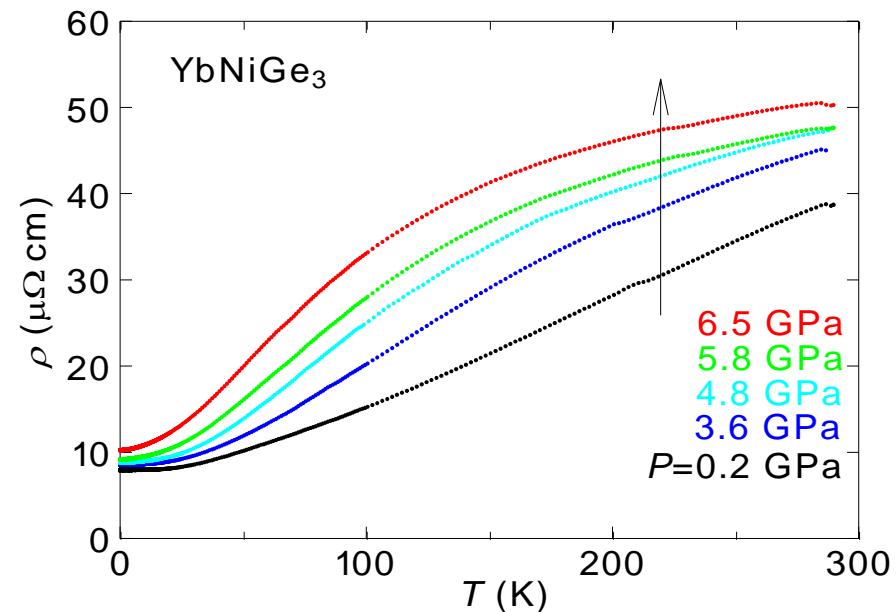


Pressure vs load



Bi : I – II (2.55 GPa), II – III(2.7 GPa), III – V(7.7 GPa)

Electrical resistivity of YbNiGe_3 under pressures

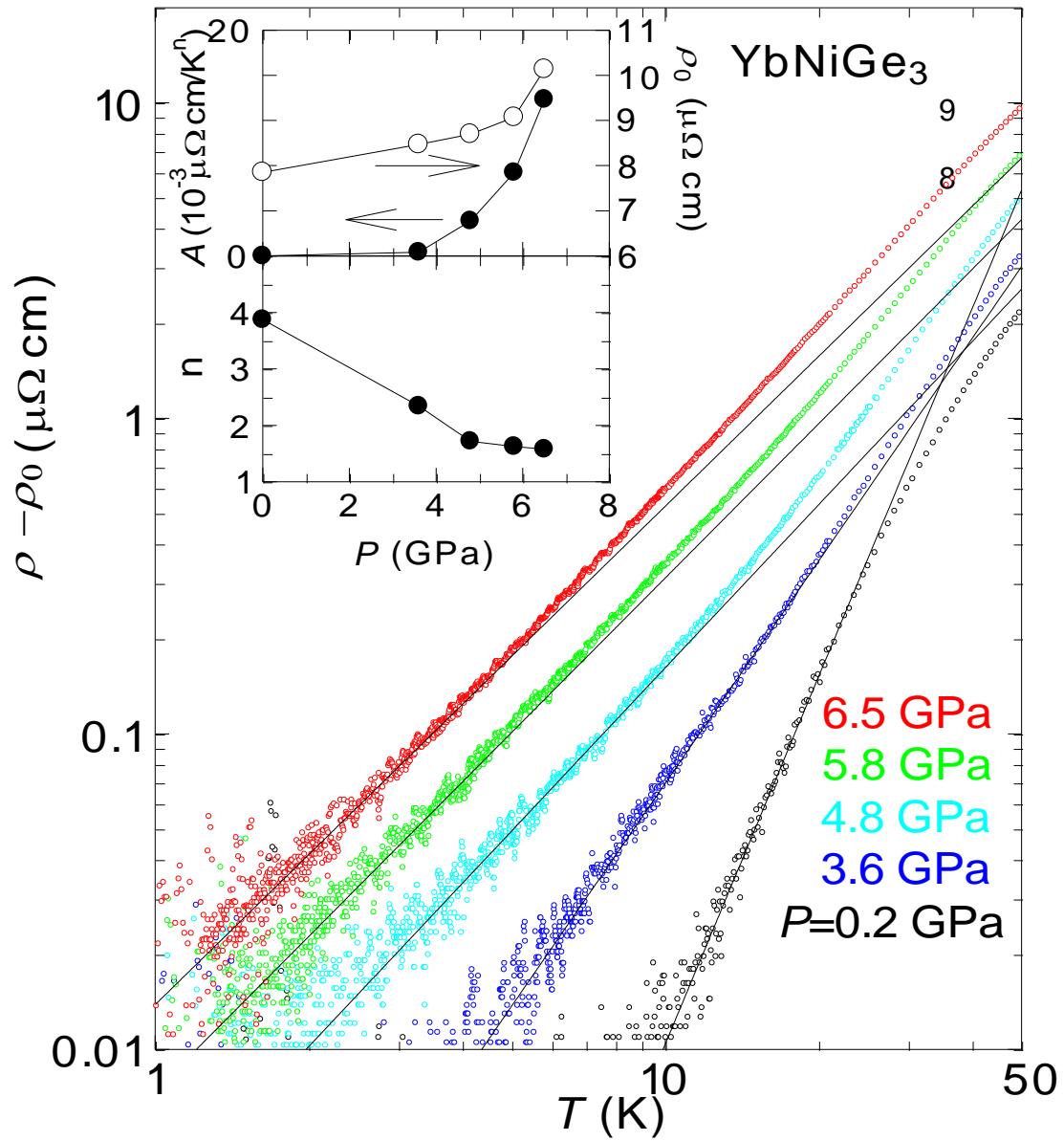


- At $P=0$, $\rho(T)$ behaves such as a normal metal without the Kondo effect.
- With increasing pressure, the resistivity increases and the Kondo effect manifests itself.

- The magnetic contribution $\Delta \rho$

$$\Delta \rho = \rho(P) - \rho(P=0.2 \text{ GPa})$$
- The maximum at T_{\max} is due to the Kondo effect.
- T_{\max} decreases linearly with pressure.
 $\Rightarrow T_K$ decreases with pressure.

Electrical resistivity of YbNiGe_3 at low temperature

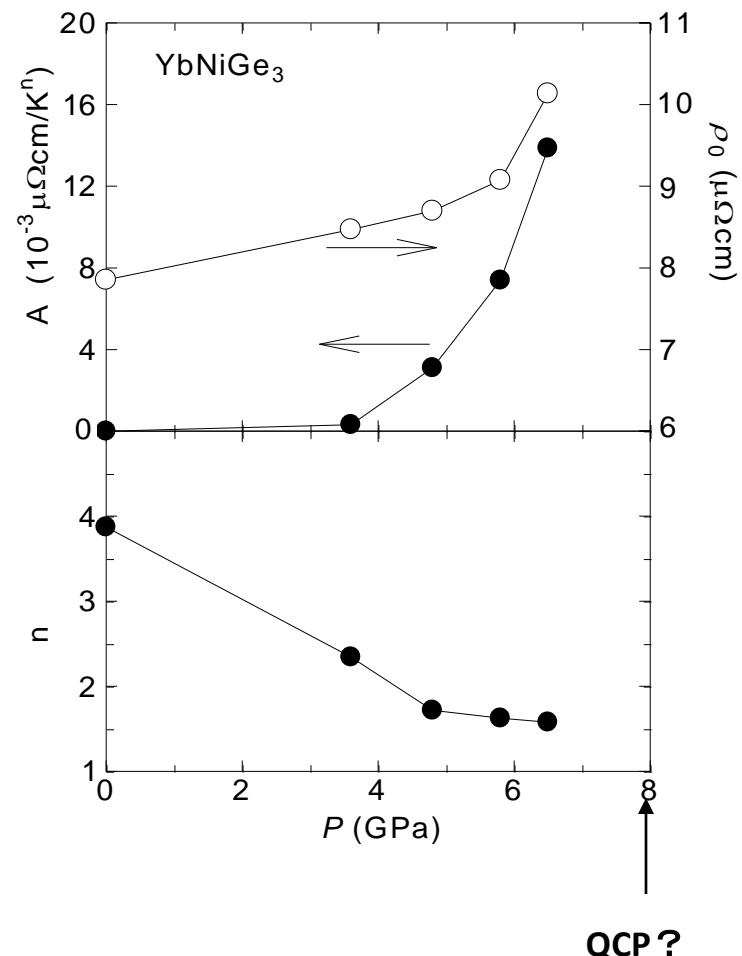


- $\rho(T) = \rho_0 + AT^n$ at $T < 20\text{ K}$
 - ρ_0 and A increase steeply for $P \geq 4\text{ GPa}$.
- ⇒ approaching QCP
- The exponent n decrease below 2 for $P \geq 4\text{ GPa}$.
 - The n reaches 1.6 at 6.5 GPa.
- ⇒ spin fluctuation for a three-dimensional antiferromagnet.

4. Summary

Electrical resistivity of YbNiGe_3 under pressures up to 7 GPa.

- T_K increases with pressure.
- The resistivity ρ is described as $\rho(T) = \rho_0 + AT^n$ at $T < 20$ K.
- For $P \geq 4$ GPa, ρ_0 and A increase steeply, and exponent n decreases below 2.
⇒ approaching QCP
- At $P = 6.5$ GPa, n reaches 1.6.
⇒ spin fluctuation for a three-dimensional antiferromagnet.
- QCP is located at about 8 GPa.



References

- [1] M. Nakashima, et al., J. Phys. Condens. Matter. **16** (2004) L255.
- [2] H. Kotegawa, et al., J. Phys. Soc. Jpn., **75** (2006) 044713.
- [3] M. A. Avila, M. Sera, and T. Takabatake, Phys. Rev. B **70** (2004) 100409(R).
- [4] K. Grube, Th. Wolf, C. Meingast and H. v. Löhneysen, Physica B **378-380** (2006) 750.
- [5] Y. Kobayashi, T. Onimaru, M. A. Avila, K. Sasai, M. Soda, K. Hirota, and T. Takabatake, J. Phys. Soc. Jpn., **77** (2008) 124701.
- [6] M. Ohashi and G. Oomi, Special Issue of the Review of High Pressure Science and Technology, **14** (2004) 292.

